

Notice of References Cited	Application/Control No. 10/577,648		Applicant(s)/Patent Under Reexamination YAMASHITA ET AL.	
	Examiner HANA A. SANEI		Art Unit 2889	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0095945	05-2005	Chang et al.	445/025
*	B	US-6,814,832	11-2004	Utsunomiya, Sumio	156/230
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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